TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (L^2 - π -MOSV)

2SK3205

Switching Regulator Applications DC-DC Converter, and Motor Drive Applications

• 4 V gate drive

 $\begin{array}{ll} \bullet & Low\ drain-source\ ON\ resistance & : R_{DS}\ (ON) = 0.36\ \Omega\ (typ.) \\ \bullet & High\ forward\ transfer\ admittance & : |Y_{fs}| = 4.5\ S\ (typ.) \\ \bullet & Low\ leakage\ current & : I_{DSS} = 100\ \mu A\ (max)\ (V_{DS} = 150\ V) \\ \bullet & Enhancement-mode & : V_{th} = 0.8 \sim 2.0\ V\ (V_{DS} = 10\ V,\ I_{D} = 1\ mA) \\ \end{array}$

Maximum Ratings (Ta = 25°C)

Characteris	stics	Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	150	V	
Drain-gate voltage (Ro	_{SS} = 20 kΩ)	V_{DGR}	150	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	I _D	5	А	
Diam current	Pulse (Note 1)	I _{DP}	20		
Drain power dissipation	n (Tc = 25°C)	P _D	20	W	
Single pulse avalanche	e energy (Note 2)	E _{AS}	71	mJ	
Avalanche current		I _{AR}	5	Α	
Repetitive avalanche e	nergy (Note 3)	E _{AR}	2	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature ra	ange	T _{stg}	-55~150	°C	

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	6.25	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	125	°C/W

Note 1: Please use devices on condition that the channel temperature is below 150°C.

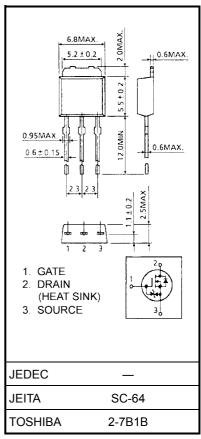
Note 2: V_{DD} = 50 V, T_{ch} = 25°C (initial), L = 4.2 mH, I_{AR} = 5 A, R_G = 25 Ω ,

Note 3: Repetitive rating; Pulse width limited by maximum channel temperature.

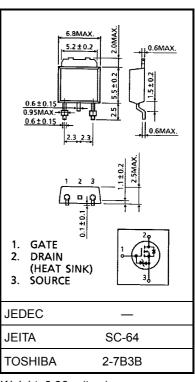
This transistor is an electrostatic sensitive device.

Please handle with caution.

Unit: mm



Weight: 0.36 g (typ.)



Weight: 0.36 g (typ.)



Electrical Characteristics (Ta = 25°C)

Charac	teristics	Symbol	Test Condition	Min	Тур.	Max	Unit	
Gate leakage cu	rrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V	_	_	±10	μΑ	
Drain cut-off cu	rent	I _{DSS}	V _{DS} = 150 V, V _{GS} = 0 V	_	_	100	μA	
Drain-source br	eakdown voltage	V _{(BR)DSS}	I _D = 10 mA, V _{GS} = 0 V	150	_	_	V	
Gate threshold v	roltage	V_{th}	V _{DS} = 10 V, I _D = 1 mA	0.8	_	2.0	V	
Drain-source ON resistance		R _{DS (ON)}	V _{GS} = 4 V, I _D = 2.5 A	_	0.54	0.75	Ω	
		R _{DS (ON)}	V _{GS} = 10 V, I _D = 2.5 A	_	0.36	0.5		
Forward transfer	admittance	Y _{fs}	V _{DS} = 10 V, I _D = 2.5 A	2.0	4.5	_	S	
Input capacitano	е	C _{iss}			330	_	pF	
Reverse transfer	se transfer capacitance C_{rss} $V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	50	_		
Output capacitance		Coss			145	_		
Switching time	Rise time	tr	V_{GS} V	_	10	_	- ns	
	Turn-on time	t _{on}		_	15	_		
	Fall time	t _f		_	10	_		
	Turn-off time	t _{off}	$V_{DD} \stackrel{.}{=} 100V$ Duty $\leq 1\%$, $t_w = 10 \mu s$	_	60	_		
Total gate charge (Gate-source plus gate-drain)		Qg		_	12	_		
Gate-source charge		Q _{gs}	$V_{DD} \approx 120 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}$		8		nC	
Gate-drain ("miller") charge		Q _{gd}			4	_		

Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}		_	_	5	Α
Pulse drain reverse current (Note 1)	I _{DRP}		_	_	20	Α
Forward voltage (diode)	V_{DSF}	I _{DR} = 5 A, V _{GS} = 0 V	_	_	-1.7	V
Reverse recovery time	t _{rr}	$I_{DR} = 5 \text{ A}, V_{GS} = 0 \text{ V}, dI_{DR} / dt = 100 \text{ A} / \mu \text{s}$	_	110	_	ns
Reverse recovery charge	Q_{rr}		_	0.47	_	nC

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